

# RF Exposure Evaluation Report

**Product** : Rear Radar  
**Trade mark** : N/A  
**Model/Type reference** : P0  
**Serial Number** : N/A  
**Report Number** : EED32Q80387802  
**FCC ID** : 2BFO8P9-EBXN10QIOF7  
**Date of Issue** : Apr. 19, 2024  
**Test Standards** : 47 CFR Part 1.1307  
47 CFR Part 1.1310  
KDB 447498 D04 Interim General RF  
Exposure Guidance v01  
**Test result** : PASS

Prepared for:

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**2377 Shenkun Road, Minhang District, Shanghai**

Prepared by:

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Apr. 19, 2024



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## 1 Version

Version No.	Date	Description
00	Apr. 19, 2024	Original

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### 3 General Information

#### 3.1 Client Information

Applicant:	Mindcruise Technology Co., Ltd
Address of Applicant:	Room 502-503, Building 1, Hongqiao International Exhibition Hall, 2377 Shenkun Road, Minhang District, Shanghai
Manufacturer:	Mindcruise Technology Co., Ltd
Address of Manufacturer:	Room 502-503, Building 1, Hongqiao International Exhibition Hall, 2377 Shenkun Road, Minhang District, Shanghai
Factory:	Mindcruise Technology Co., Ltd
Address of Factory:	1-4 Floors(D) North of No.3 Factory Building ,High-tech Industrial Park, High Tech Zone, Yandu District, Yancheng City, Jiangsu

#### 3.2 General Description of EUT

Product Name:	Rear Radar
Model No.:	P0
Trade mark:	N/A
Product Type:	<input checked="" type="checkbox"/> Mobile <input type="checkbox"/> Portable <input type="checkbox"/> Fix Location
Type of Modulation:	FMCW
Operating Frequency	76.50GHz
Test Power Grade:	Default
Test Software of EUT:	N/A
Antenna Type:	Chip Antenna
Antenna Gain:	15.9dBi
Power Supply:	DC 12V
Test Voltage:	DC 12V
Sample Received Date:	Mar. 28, 2024
Sample tested Date:	Mar. 28, 2024 to Apr. 17, 2024
Remark:	Company Name and Address shown on Report, the sample(s) and sample Information was/ were provided by the applicant who should be responsible for the authenticity which CTI hasn't verified.

### 3.3 Test Location

All tests were performed at:

Centre Testing International Group Co., Ltd

Building C, Hongwei Industrial Park Block 70, Bao'an District, Shenzhen, China

Telephone: +86 (0) 755 33683668 Fax:+86 (0) 755 33683385

No tests were sub-contracted.

FCC Designation No.: CN1164

### 3.4 Deviation from Standards

None.

### 3.5 Abnormalities from Standard Conditions

None.

### 3.6 Other Information Requested by the Customer

None.



## 4 SAR Evaluation

### 4.1 RF Exposure Compliance Requirement

#### 4.1.1 Limits

According to KDB 447498 D04 Interim General RF Exposure Guidance v01, for all devices, MPE limits in § 1.1310(e)(1) - Table 1. The SAR-based exemption formula of § 1.1310(e)(1), Table 1 to § 1.1310(e)(1) sets forth limits for Maximum Permissible Exposure (MPE) to radiofrequency electromagnetic fields.

Table 1 to § 1.1310(e)(1)—Limits for Maximum Permissible Exposure (MPE)

Frequency range (MHz)	Electric field strength (V/m)	Magnetic field strength (A/m)	Power density (mW/cm <sup>2</sup> )	Averaging time (minutes)
(i) Limits for Occupational/Controlled Exposure				
0.3–3.0	614	1.63	*(100)	≤6
3.0–30	1842/f	4.89/f	*(900/f <sup>2</sup> )	<6
30–300	61.4	0.163	1.0	<6
300–1,500			f/300	<6
1,500–100,000			5	<6
(ii) Limits for General Population/Uncontrolled Exposure				
0.3–1.34	614	1.63	*(100)	<30
1.34–30	824/f	2.19/f	*(180/f <sup>2</sup> )	<30
30–300	27.5	0.073	0.2	<30
300–1,500			f/1500	<30
1,500–100,000			1.0	<30

f = frequency in MHz. \* = Plane-wave equivalent power density.

Friis Formula,

Friis transmission formula:  $P_d = (P_{out} \cdot G) / (4 \cdot \pi \cdot r^2)$ ;

Where,

$P_d$  = power density in mW/cm<sup>2</sup>

$P_{out}$  = output power to antenna in mW  $G$  = gain of antenna in linear scale  $\pi = 3.1416$ ;

$R$  = distance between observation point and center of the radiator in cm .

General population/uncontrolled exposure limits apply in situations in which the general public may be exposed, or in which persons who are exposed as a consequence of their employment may not be fully aware of the potential for exposure or cannot exercise control over their exposure. For example, RF sources intended for consumer use shall be subject to the limits for general population/uncontrolled exposure in this section.

#### 4.1.2 Test Mode

TX mode\_Make EUT continuously emit radar signals.

### 4.1.3 EUT RF Exposure Evaluation

For Stand alone:

Frequency (GHz)	R (cm)	Corrected EIRP (dBm/MHz)	Tune-up EIRP (dBm)	Tune-up EIRP (mW)	Power density (mW/cm <sup>2</sup> )	Limit (mW/cm <sup>2</sup> )	Result
76.50	20	32.92	35.00	3162.2777	0.6291	1	PASS

**Note:**

- ①  $EIRP(mW) = 10^{(EIRP(dBm)/10)}$ ;
- ② The estimation distance is 20cm;
- ③ Tune-up EIRP was declared by manufacturer;
- ④ The test data of Corrected EIRP please refer to the report of EED32Q80387801 and only the worst case data was recorded in the report.

The test report is effective only with both signature and specialized stamp, The result(s) shown in this report refer only to the sample(s) tested. Without written approval of CTI, this report can't be reproduced except in full.

\*\*\* End of Report \*\*\*